

ITS4200S-ME-P

Smart High-Side NMOS-Power Switch

Data Sheet

Rev 1.0, 2012-09-01

Standard Power



Smart High-Side NMOS-Power Switch

ITS4200S-ME-P



1 Overview

Features

- · CMOS compatible input
- Switching all types of resistive, inductive and capacitive loads
- · Fast demagnetization of inductive loads
- Very low standby current
- Optimized Electromagnetic Compatibility (EMC)
- Overload protection
- · Current limitation
- Short circuit protection
- · Thermal shutdown with restart
- Overvoltage protection (including load dump)
- · Reverse battery protection with external resistor
- Loss of GND and loss of Vbb protection
- Electrostatic Discharge Protection (ESD)
- Green Product (RoHS compliant)

ITS4200S-ME-P is not qualified and manufactured according to the requirements of Infineon Technologies with regards to automotive and/or transportation applications.



The ITS4200S-ME-P is a protected single channel Smart High-Side NMOS-Power Switch in a SOT-223-4 package with charge pump and CMOS compatible input. The device is monolithically integrated in Smart technology.

Product Summary

Overvoltage protection $V_{\rm SAZmin}$ = 47V Operating voltage range: 11V < $V_{\rm S}$ < 45V On-state resistance $R_{\rm DSON}$ = typ 150m Ω Nominal load current $I_{\rm LNOM}$ = 1.4A

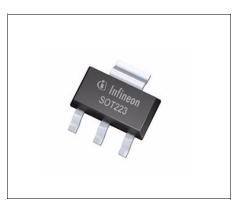
Operating Temperature range: Tj = -40°C to 125°C

Standby Current: $I_{SSTB} = 50 \mu A$

Application

- All types of resistive, inductive and capacitive loads
- Power switch for 12V and 24V DC applications with CMOS compatible control interface
- Driver for electromagnetic relays
- Power managment for high-side-switching with low current consumption in OFF-mode

Туре	Package	Marking
ITS4200S-ME-P	SOT-223-4	I200SP



SOT-223-4



Block Diagram and Terms

2 Block Diagram and Terms

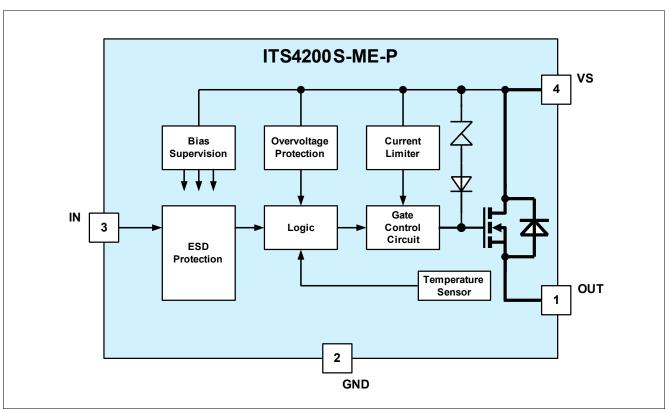


Figure 1 Block diagram

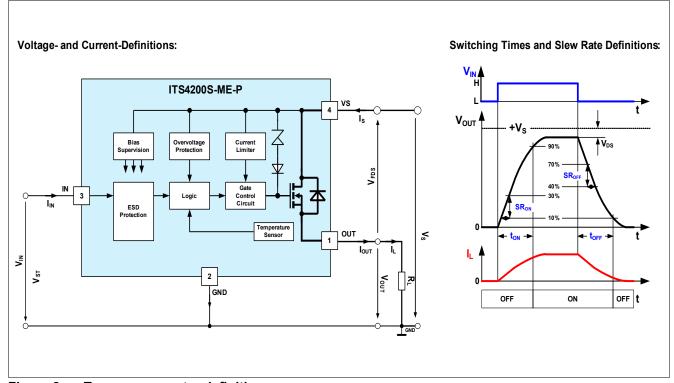


Figure 2 Terms - parameter definition



Pin Configuration

3 Pin Configuration

3.1 Pin Assignment

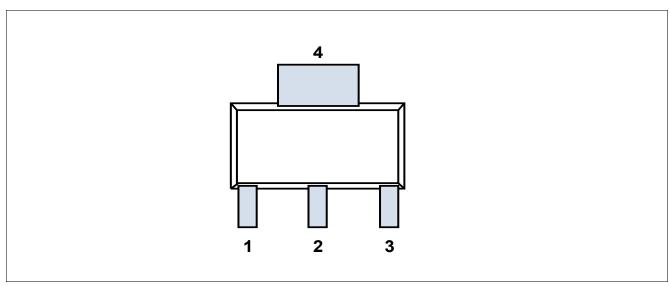


Figure 3 Pin configuration top view, SOT-223-4

3.2 Pin Definitions and Functions

Pin	Symbol	Function
1	OUT	Output to the load
2	GND	Logic ground
3	IN	Input, controles the power switch; the powerswitch is ON when high
4	VS	Supply voltage (design the wiring for the maximum short circuit current and also for low thermal resistance)



General Product Characteristics

4 General Product Characteristics

4.1 Absolute Maximum Ratings

Table 1 Absolute maximum ratings²⁾ at T_j = 25°C unless otherwise specified. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms"

Parameter	Symbol		Value	S	Unit	Note / Test Condit ion	Number
		Min.	Тур.	Max.	_		
Supply voltage VS	1		<u> </u>	- 1			
Voltage	V_{S}			48	V		4.1.1
Ground Current IGND	<u> </u>						
Reverse Ground Current	I_{GND}	- 0.5			Α		4.1.2
Output stage OUT	-			-		•	
Output Current; (Short circuit current see electrical characteristics)	I_{OUT}	-1		self limited	А		4.1.3
Input IN	"	"		"			1
Voltage	V_{IN}	-10		V_{S}	V		4.1.4
Current	I_{IN}	-5		5	mA		4.1.5
Temperatures						'	•
Junction Temperature	$T_{\rm j}$	-40		125	°C		4.1.6
Storage Temperature	T_{stg}	-55		125	°C		4.1.7
Power dissipation	<u> </u>						
Ta = 25 °C ¹⁾	P_{tot}			1.4	W		4.1.8
Inductive load switch-off energy dissipa						'	•
Tj = 125 °C; V_S =13.5V; IL= 1.0A ²⁾	E_{AS}			160	mJ	single pulse	4.1.9
ESD Susceptibility	- '	•			•	•	
ESD susceptibility (input pin)	V_{ESD}	-1		1	kV	HBM ³⁾	4.1.10
ESD susceptibility (all other pins)	V_{ESD}	-5		5	kV	HBM ³⁾	4.1.11
						,	

¹⁾ Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6 cm2 (one layer, 70mm thick) copper area for Vbb connection. PCB is vertical without blown air

Note: Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" the normal operating range. Protection functions are neither designed for continuous nor repetitive operation.

²⁾ Not subject to production test, specified by design

³⁾ ESD susceptibility HBM according to EIA/JESD 22-A 114.



General Product Characteristics

4.2 Functional Range

Table 2 Funtional Range

Parameter	Symbol		Value	s	Unit	Note / Test Condition	Number
		Min.	Тур.	Max.			
Nominal Operating Voltage	V_{S}	11		45	V	$V_{\rm S}$ increasing	4.2.1
Continuous Input Voltage	V_{IN}	-3		V_{S}	V		4.2.2

Note: Within the functional range the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the related electrical characteristics table.

4.3 Thermal Resistance

This thermal data was generated in accordance to JEDEC JESD51 standards. More information on www.jedec.org

Table 3 Thermal Resistance¹⁾

Parameter	Symbol		Values	;	Unit	Note / Test Condition	Number
		Min.	Тур.	Max.			
Thermal Resistance - Junction to pin5	$R_{ m thj-pin5}$		41.8		K/W		4.3.1
Thermal Resistance - Junction to Ambient - 1s0p, minimal footprint	$R_{ m thJA_1s0p}$		155.5		K/W	2)	4.3.2
Thermal Resistance - Junction to Ambient - 1s0p, 300mm ²	$R_{\mathrm{thJA_1s0p_300mm}}$		76.1		K/W	3)	4.3.3
Thermal Resistance - Junction to Ambient - 1s0p, 600mm ²	$R_{\mathrm{thJA_1s0p_600mm}}$		67.1		K/W	4)	4.3.4
Thermal Resistance - Junction to Ambient - 2s2p	$R_{\mathrm{thJA_2s2p}}$		93.6		K/W	5)	4.3.5
Thermal Resistance - Junction to Ambient with thermal vias - 2s2p	$R_{\mathrm{thJA_2s2p}}$		50.0		K/W	6)	4.3.6

¹⁾ Not subject to production test, specified by design

- 2) Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, footprint; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70 μ m Cu.
- 3) Specified $R_{\rm thJA}$ value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, Cu, 300mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70 μ m Cu.
- 4) Specified R_{thJA} value is according to Jedec JESD51-3 at natural convection on FR4 1s0p board, 600mm²; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 1x 70 μ m Cu.
- 5) Specified $R_{\rm thJA}$ value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70 μ m Cu, 2 x 35 μ m Cu).
- 6) Specified $R_{\rm thJA}$ value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board with two thermal vias; the Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70 μ m Cu, 2 x 35 μ m Cu. The diameter of the two vias are equal 0.3mm and have a plating of 25um with a copper heatsink area of 3mm x 2mm). JEDEC51-7: The two plated-through hole vias should have a solder land of no less than 1.25 mm diameter with a drill hole of no less than 0.85 mm diameter.

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Electrical Characteristics

5 Electrical Characteristics

Table 4 $V_S = 15V$ to 30V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at $V_S = 13.5V$, Tj = 25°C

Parameter	Symbol	Values			Unit	Note /	Number
		Min.	Тур.	Max.		Test Condition	
Powerstage	-1		1	"	"		1
NMOS ON Resistance	R_{DSON}	_	150	200	mΩ	I_{OUT} = 0.5A; T_{j} = 25°C; V_{IN} = 5V	5.0.1
NMOS ON Resistance	R_{DSON}	_	270	320	mΩ	I_{OUT} = 0.5A; T_{j} = 125°C; V_{IN} = 5V	5.0.2
Nominal Load Current; device on PCB ¹⁾	I_{LNOM}	1.4	-	_	А	T_{pin5} = 85°C	5.0.3
Timings of Power Stages ²⁾	-1						
Turn ON Time(to 90% of $V_{\rm out}$); L to H transition of $V_{\rm IN}$	t _{ON}		50	100	μs	$V_{\rm S}$ =15V; $R_{\rm L}$ = 47 Ω	5.0.4
Turn OFF Time (to 10% of $V_{\rm out}$); H to L transition of $V_{\rm IN}$	t_{OFF}		75	150	μs	$V_{\rm S}$ =15V; $R_{\rm L}$ = 47 Ω	5.0.5
ON-Slew Rate (10 to 30% of $V_{\rm out}$); L to H transition of $V_{\rm IN}$	SR _{ON}		1	2	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.6
OFF-Slew Rate; $dV_{\rm OUT}/dt_{\rm ON}$ (70 to 40% of $V_{\rm out}$); H to L transition of $V_{\rm IN}$	SR _{OFF}		1	2	V/µs	$V_{\rm S}$ =13.5V; $R_{\rm L}$ = 47 Ω	5.0.7
Under voltage lockout (charge pu	mp start-	stop-re	start)	"	"		1
Supply undervoltage; charge pump stop voltage	V_{SUV}	7.0		10.5	V	$V_{\rm S}$ decreasing	5.0.8
Supply startup voltage; Charge pump restart voltage	V_{SSU}			11	V	$V_{\rm S}$ increasing	5.0.9
Current consumption	-1		1	"	"		1
Operating current	I_{GND}		1.0	1.6	mA	V_{IN} = 5V	5.0.10
Standby current	I_{SSTB}		10	25	μA	V_{IN} = 0V; V_{OUT} = 0V -40°C < T_{i} < 85°C	5.0.11
Standby current	I_{SSTB}			50	μΑ	V_{IN} = 0V; V_{OUT} = 0V T_{i} = 125°C	5.0.12
Output leakage current	I_{OUTLK}		3.5	10	μA	V_{IN} = 0V; V_{OUT} = 0V	5.0.13
Protection functions 3)		+					!
Initial peak short circuit current limit	I_{LSCP}			4.5	А	$T_{\rm j}$ = -40°C; $V_{\rm S}$ = 20V; $V_{\rm IN}$ = 5.0V; $t_{\rm m}$ =150 μ s	5.0.14
Initial peak short circuit current limit	I_{LSCP}		3.0		A	$T_{\rm j}$ = 25°C; $V_{\rm S}$ = 20V; $V_{\rm IN}$ = 5.0V; $t_{\rm m}$ =150 μ s	5.0.15



Electrical Characteristics

Table 4 $V_S = 15V$ to 30V; Tj = -40°C to 125°C; all voltages with respect to ground. Currents flowing into the device unless otherwise specified in chapter "Block Diagram and Terms". Typical values at $V_S = 13.5V$, Tj = 25°C

Parameter	Symbol		Value	s	Unit	Note / Test Condition	Number
		Min.	Тур.	Max.			
Initial peak short circuit current limit	I_{LSCP}	1.4			A	$T_{\rm j}$ =125°C; $V_{\rm S}$ = 20V ; $V_{\rm IN}$ = 5.0V; $t_{\rm m}$ =150 μ s	5.0.16
Repetitive short circuit current limit $T_{\rm j} = T_{\rm jTrip}$; see timing diagrams	I_{LSCR}		2.2		А	V _{IN} = 5.0V	5.0.17
Output clamp at $V_{\rm OUT}$ = $V_{\rm S}$ - $V_{\rm DSCL}$ (inductive load switch off)	V_{DSCL}	62	68		V	$I_{\rm S}$ = 4mA	5.0.18
Overvoltage protection $V_{\text{OUT}} = V_{\text{S}} - V_{\text{ONCL}}$	V_{SAZ}	47			V	$I_{\rm S}$ = 4mA	5.0.19
Thermal overload trip temperature	T_{jTrip}	135			°C		5.0.20
Thermal hysteresis	T_{HYS}		10		K		5.0.21
Reverse Battery ⁴⁾							
Continuous reverse battery voltage	V_{SREV}	- 45			V		5.0.22
Forward voltage of the drain-source reverse diode	V_{FDS}		0.6	1.2	V	I_{FDS} = 1A; V_{IN} = 0V; T_{j} = 125°C	5.0.23
Input interface; pin IN	1				l .		
Input turn-ON threshold voltage	V_{INON}	3.0			V		5.0.24
Input turn-OFF threshold voltage	V_{INOFF}			1.8	V		5.0.25
Input threshold hysteresis	V_{INHYS}		0.2		٧		5.0.26
Off state input current	I_{INOFF}	20			μΑ	V _{IN} < 1.8V	5.0.27
On state input current	I_{INON}	1		110	μΑ	$V_{\rm IN} = V_{\rm S} < 15 {\rm V}$	5.0.28
Input resistance	R_{IN}	1.5	3.5	5.0	kΩ		5.0.29
Input Switch ON Delay Time	$t_{\sf dON}$	150	350		μs		5.0.30

¹⁾ Device on 50mm x 50mm x 1,5mm epoxy FR4 PCB with 6cm² (one layer copper 70um thick) copper area for supply voltage connection. PCB in vertical position without blown air.

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²⁾ Timing values only with high slewrate input signal; otherwise slower.

³⁾ Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

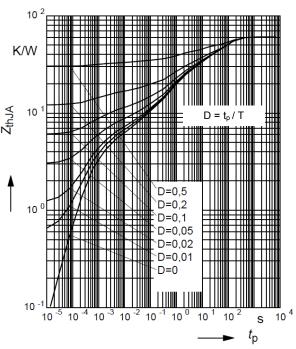
⁴⁾ Requires a 150W resistor in GND connection. The reverse load current trough the intrinsic drain-source diode of the power-MOS has to be limited by the connected load. Power dissipation is higher compared to normal operation due to the votage drop across the drain-source diode. The temperature protection is not functional during reverse current operation! Input current has to be limited (see max ratings).



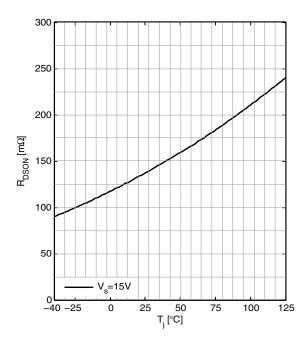
6 Typical Performance Graphs

Typical Characterisitics

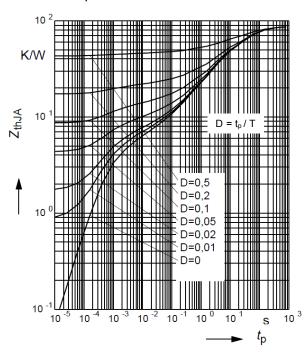
Transient Thermal Impedance Z_{thJA} versus Pulse Time t_p @ 6cm² heatsink area



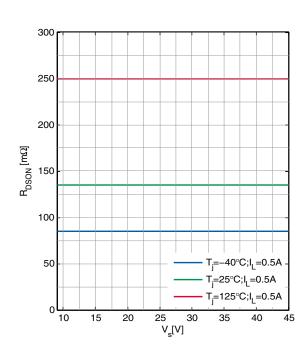
On-Resistance $R_{\rm DSON}$ versus Junction Temperature $T_{\rm i}$



Transient Thermal Impedance Z_{thJA} versus Pulse Time t_p @ min footprint



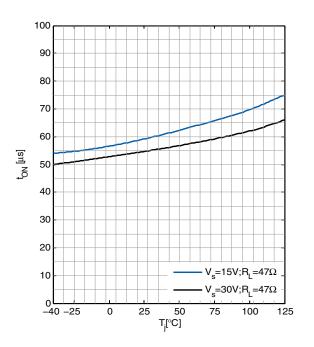
On-Resistance $R_{\rm DSON}$ versus Supply Voltage $V_{\rm S}$



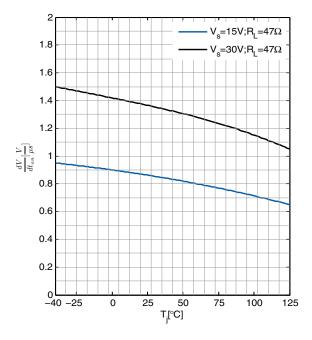


Typical Characterisitics

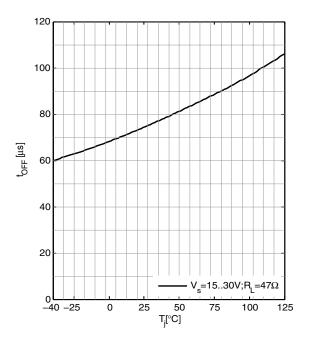
Switch ON Time t_{ON} versus Junction Temperature T_{i}



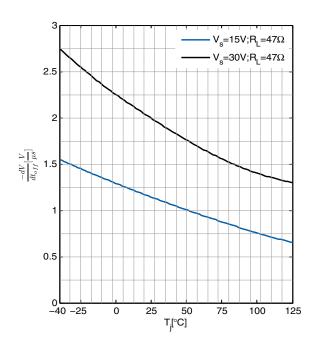
ON Slewrate SR_{ON} versus Junction Temperature T_i



Switch OFF Time t_{OFF} versus Junction Temperature T_{i}



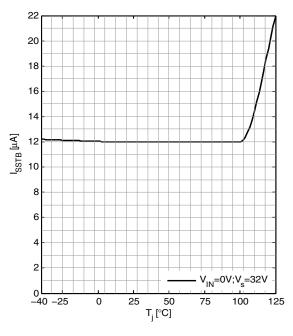
OFF Slewrate SR_{OFF} versus Junction Temperature T_i



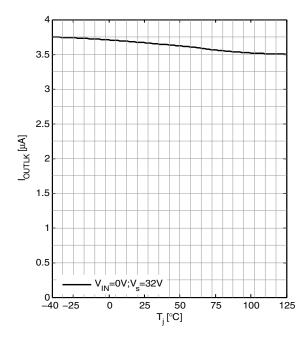


Typical Characterisitics

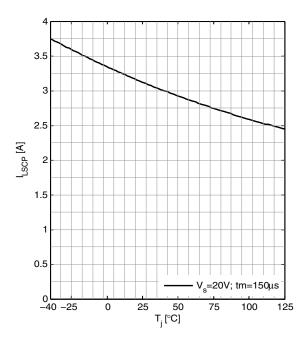
Standby Current $I_{\rm SSTB}$ versus Junction Temperature $T_{\rm i}$



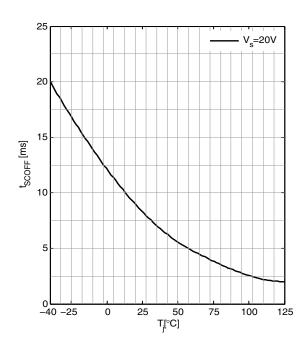
Output Leakage current $I_{\rm OUTLK}$ versus Junction Temperature $T_{\rm i}$



Initial Peak Short Circuit Current Limt $I_{\rm LSCP}$ versus Junction Temperature $T_{\rm i}$



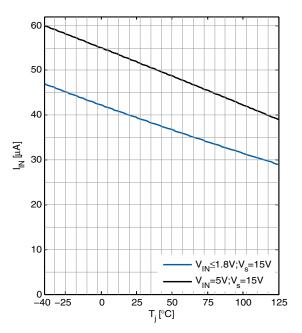
Initial Short Circuit Shutdown time $t_{\rm SCOFF}$ versus Junction Temperature $T_{\rm i}$



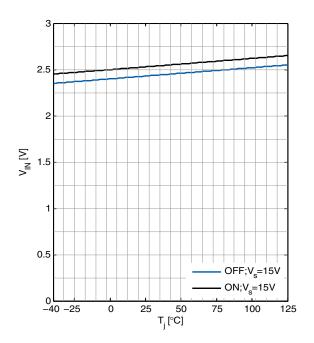


Typical Characterisitics

Input Current Consumption $I_{\rm IN}$ versus Junction Temperature $T_{\rm j}$

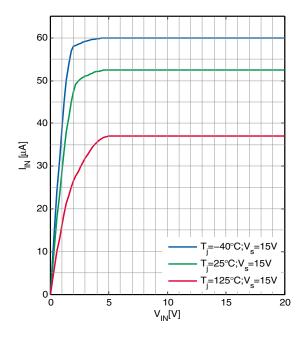


Input Threshold voltage $V_{\mathrm{INH,L}}$ versus Junction Temperature T_{i}

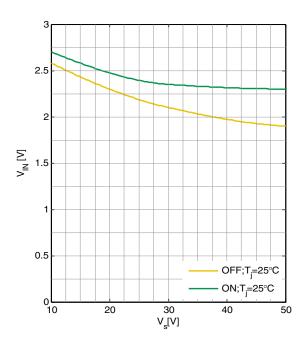


Initial Peak Short Circuit Current Limt $I_{\rm LSCP}$ versus Supply Voltage $V_{\rm S}$

Input Current Consumption $I_{\rm IN}$ versus Input voltage $V_{\rm IN}$

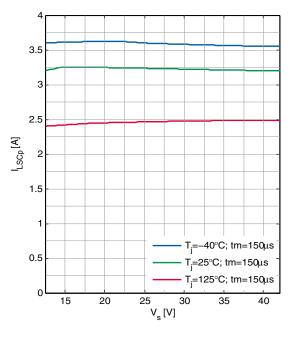


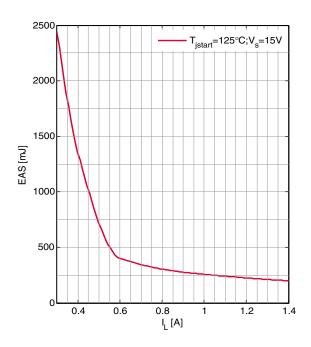
Input Threshold voltage $V_{\mathrm{INH,L}}$ versusSupply Voltage V_{S}



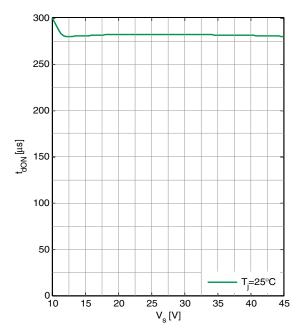
Max. allowable Inductive single pulse Switch-off Energy $E_{\rm AS}$ versus Load current $I_{\rm L}$







Input Switch ON Delay Time $\rm t_{dON}$ versus Supply Voltage $V_{\rm S}$





7 Application Information

7.1 Application Diagram

The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty for a certain functionality, condition or quality of the device.

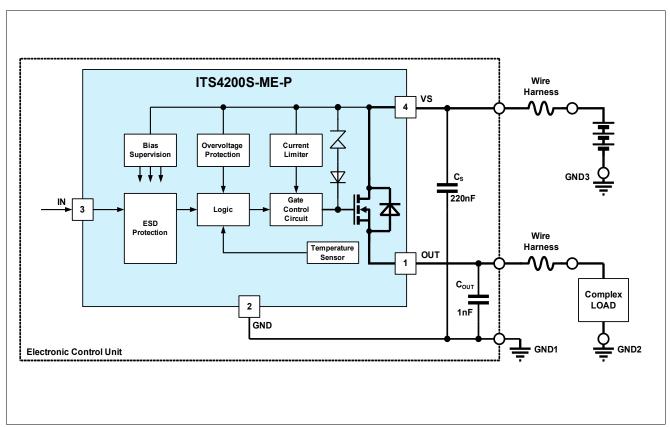


Figure 4 Application Diagram

The ITS4200S-ME-P can be connected directly to a supply network. It is recommended to place a ceramic capacitor (e.g. $C_S = 220$ nF) between supply and GND to avoid line disturbances. Wire harness inductors/resistors are sketched in the application circuit above.

The complex load (resistive, capacitive or inductive) must be connected to the output pin OUT.

A built-in current limit protects the device against destruction.

The ITS4200S-ME-P can be switched on and off with standard logic ground related logic signal at pin IN. In standby mode (IN=L) the ITS4200S-ME-P is deactivated with very low current consumption.

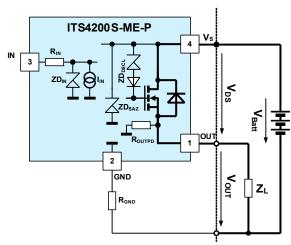
The output voltage slope is controlled during on and off transistion to minimize emissions. Only a small ceramic capacitor COUT=1nF is recommended to attenuate RF noise.

In the following chapters the main features, some typical waverforms and the protection behaviour of the ITS4200S-ME-P is shown. For further details please refer to application notes on the Infineon homepage.

7.2 Special Feature Description

Supply over voltage:

Supply reverse voltage:



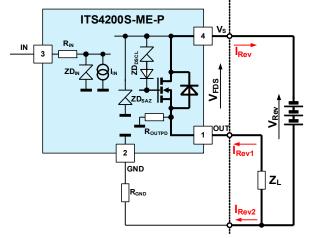
If over-voltage is applied to the V_S -Pin:

Voltage is limited to V_{ZDSAZ} ; current can be calculated:

 $I_{ZDSAZ} = (V_S - V_{ZDSAZ}) / R_{GND}$

A typical value for RGND is 150Ω .

In case of ESD pulse on the input pin there is in both polarities a peak current $I_{INpeak} \sim V_{ESD} / R_{IN}$



If reverse voltage is applied to the device:

1.) Current via load resistance RL:

 $I_{Rev1} = (V_{Rev} - V_{FDS}) / R_L$

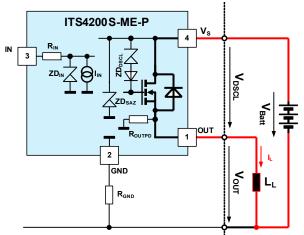
2.) Current via Input pin IN and dignostic pin ST:

 $I_{Rev2} = I_{ST} + I_{IN} \sim (V_{Rev} - V_{CC})/R_{IN} + (V_{Rev} - V_{CC})/R_{ST1,2}$ Current I_{ST} must be limited with the extrernal series resistor R_{STS} . Both currents will sum up to:

$$I_{Rev} = I_{Rev1} + I_{Rev2}$$

Drain-Source power stage clamper V_{DSCL}:

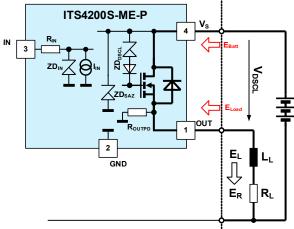
Energy calculation:



When an inductive load is switched off a current path must be established until the current is sloped down to zero (all energy removed from the inductive load). For that purpose the series combination Z_{DSCL} is connected between Gate and Drain of the power DMOS acting as an active clamp.

When the device is switched off, the voltage at OUT turns negative until V_{DSCL} is reached.

The voltage on the inductive load is the difference between V_{DSCL} and $V_{\text{S}}.$



Energy stored in the load inductance is given by : $E_1 = I_1 {}^{2*}L/2$

While demagnetizing the load inductance the energy dissipated by the Power-DMOS is:

$$E_{AS} = E_S + E_L - E_R$$

With an approximate solution for $R_L = 0\Omega$:

$$E_{AS} = \frac{1}{2} * L * I_{L}^{2} * \{(1 - V_{S} / (V_{S} - V_{DSCL}))\}$$

Figure 5 Special feature description

7.3 Typical Application Waveforms

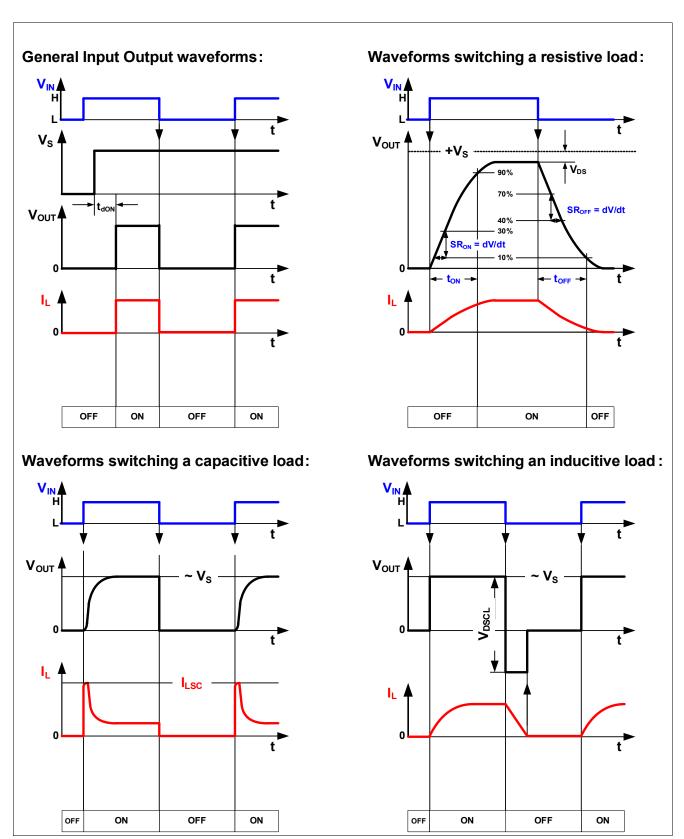


Figure 6 Typical application waveforms of the ITS4200S-ME-P

7.4 Protection Behavior

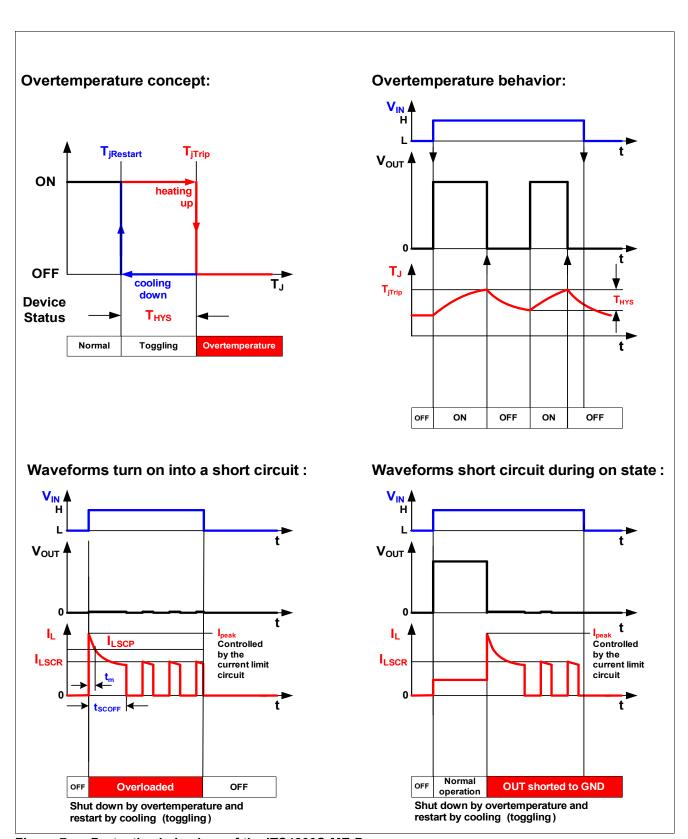


Figure 7 Protective behaviour of the ITS4200S-ME-P



Package outlines and footprint

8 Package outlines and footprint

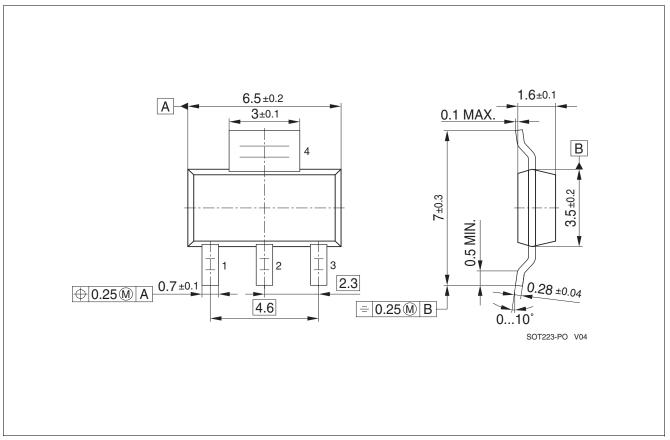


Figure 8 SOT-223-4 (Plastic Dual Small Outline Package, RoHS-Compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020



Revision History

9 Revision History

Revision	Date	Changes
V 1.0	12-09-01	Datasheet release

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